

# Honeywell

## Executive Summary

Honeywell HLT2000, **a two-component, dispensable thermal gel** with ultra-high compressibility enables low stress and excellent conformity to mating surfaces. It is designed to minimize thermal resistance at interfaces, and maintain excellent performance through reliability testing.

Based on a novel polymer system, this material exhibits excellent reliability. A proprietary filler material provides high thermal conductivity  $2.0\text{W/m} \cdot \text{K}$  suitable for high performance devices.

### Conclusion :

HLT2000 has excellent thermal stability after different long term reliability tests including, D85(  $85^{\circ}\text{C}$ & $85\%\text{RH}$ ) 1000hrs, Thermal Shock 1000cycles and HTB(High Temperature Baking)  $125^{\circ}\text{C}$  1000hrs.

## Introduction

### • Purpose

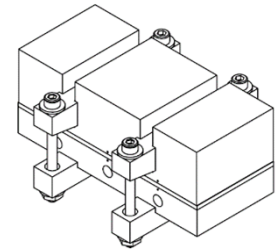
- This test is intended to provide the thermal performance stability data of Honeywell Thermal Interface Material via different accelerated conditions.

### • Test Method

- ASTM D5470 modified.

### • Test Procedure

- The test fixture is rectangular with surface area of 10 in<sup>2</sup> (2" x 5")
- Aluminum heater plate and an extruded aluminum heat sink "cooler plate".
- The heater plate contains 3 holes for insertion of cartridge heaters.
- Both plates contain 3 sets of thermocouple holes drilled for measurement of the temperature very near the surfaces mated by the **thermal gel**.
- Each test fixture accommodates 3 test positions.
- A specified power from a power supply is input to the heaters to obtain a constant 70°C across the heater plate.
- A cooling fan (not pictured) is centered on top of the heat sink during testing to facilitate realistic air flow and cooling. Test values are measured in an ambient laboratory environment.
- Measure  $\Delta T$  of the top and bottom surface before and after.



### • Test Items/Condition

- |                                      |         |
|--------------------------------------|---------|
| - 85°C& 85%RH                        | 1000hrs |
| - Temperature Shock Test             | 1000x   |
| - High Temperature Baking Test 125°C | 1000hrs |

## Thermal Impedance Test Method: ASTM D5470

$$\text{Hot side heat flow } Q_h = K_m \times A \times \frac{T_{h3} - T_{h1}}{X_1 + X_2}$$

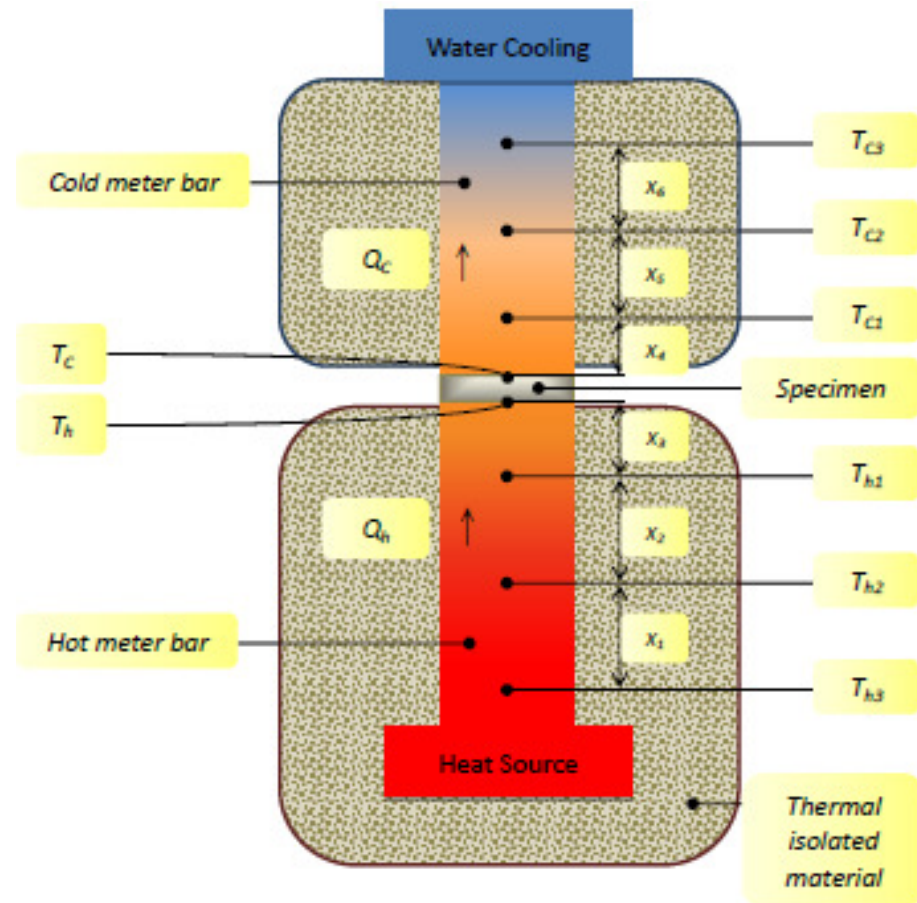
$$\text{Cold side heat flow } Q_c = K_m \times A \times \frac{T_{c1} - T_{c3}}{X_5 + X_6}$$

$$\text{Average heat flow } Q_{ave} = \frac{(Q_h + Q_c)}{2}$$

$$\text{Hot side surface temp. } T_h = T_{h1} - \frac{X_3}{X_1 + X_2} (T_{h3} - T_{h1})$$

$$\text{Cold side surface temp. } T_c = T_{c1} - \frac{X_4}{X_5 + X_6} (T_{c3} - T_{c1})$$

$$\text{Thermal impedance } Imp = R \times A = \frac{T_h - T_c}{Q_{ave}} \times A$$



## Reliability Test Condition

- **85°C & 85%RH Test (D85)**

- Standard: IEC-68-2-30
- Testing Condition: 85°C, 85%RH, **1000 hours**
- Chamber supplier: ESPEC
- Objective: High temperature with high humidity on the thermal performance of the test structure.



TH D85 chamber

- **Temperature Shock Test**

- Standard: IEC 60068-2-14
- Testing Condition: -40°C to 125°C, 1000cycles
- Chamber supplier: ESPEC
- Objective: Determine the resistance of TIM to extremes of high and low temperatures shock, and its ability to withstand cyclical stresses.



Thermal Shock chamber

- **High Temperature Baking**

- Standard: JESD22-A103C
- Testing Condition: 125°C, **1000 hours**
- Oven supplier: BINDER
- Objective: Accelerate changes in TIM's material and performance characteristics relative to prolonged and elevated temperature.

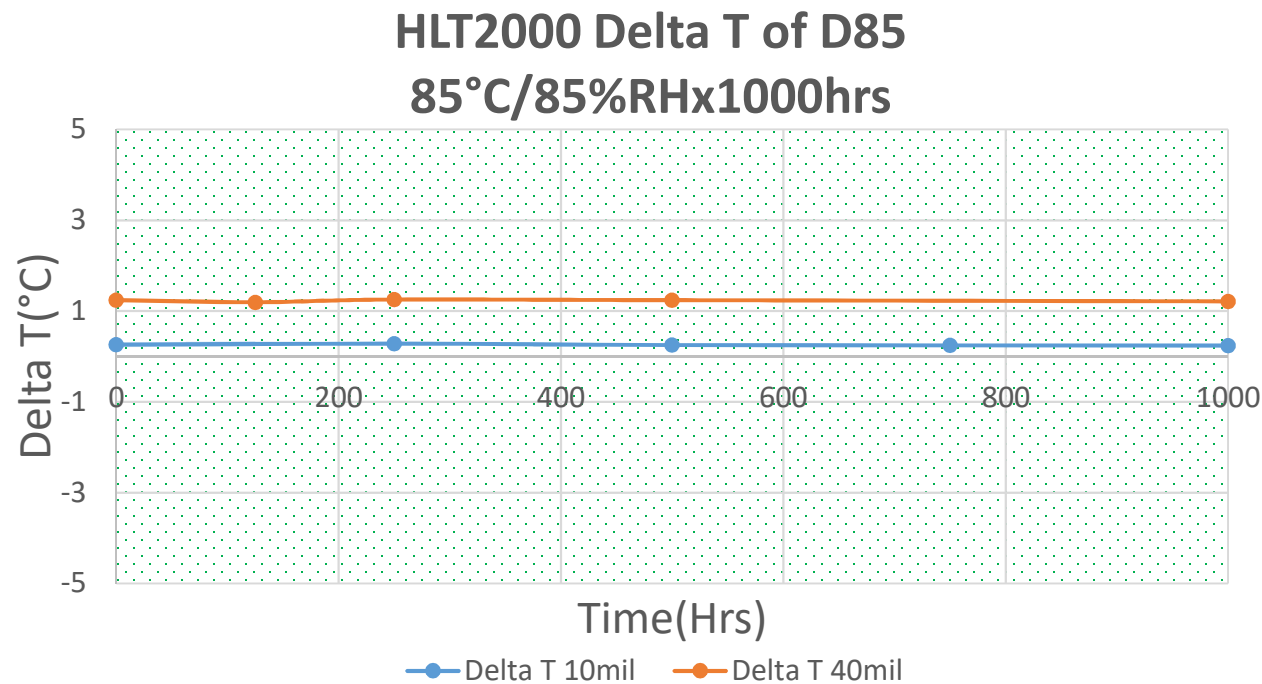


Oven

## 85°C & 85%RH(D85)

Standard : IEC-68-2-30

- Testing Condition: 85°C, 85%RH, 1000 hours
- Objective: High temperature with high humidity on the thermal performance of the test structure



TH D85 chamber

**HLT2000 remain reliable up to 1000hrs for D85**

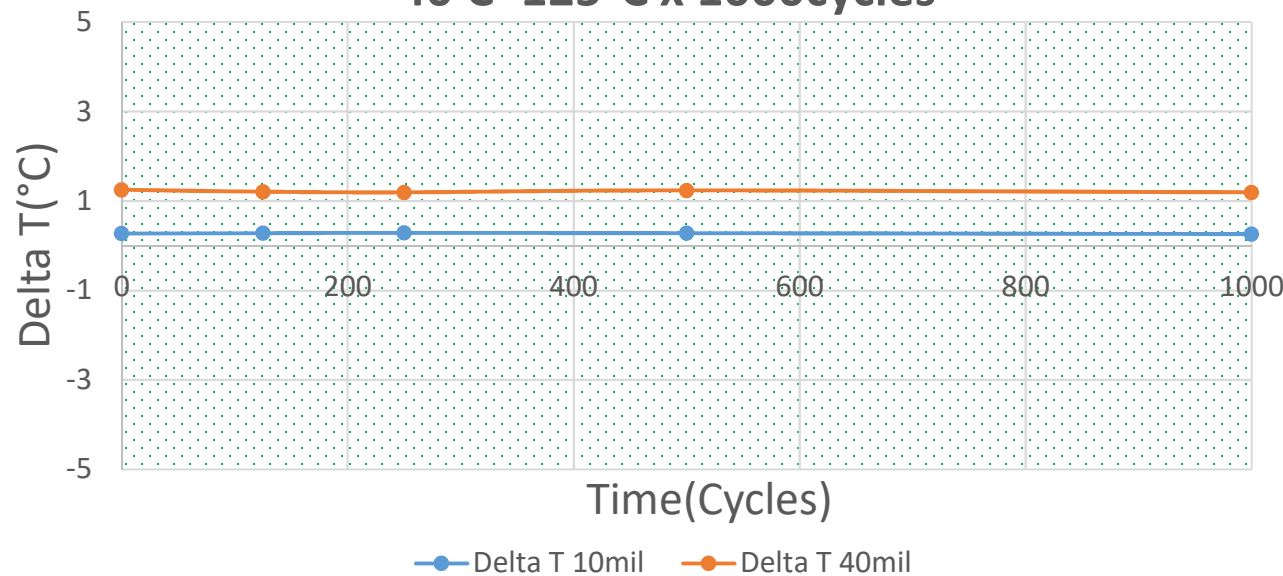
## Thermal Shock Test Testing

Standard: IEC 60068-2-14

- Testing Condition: -40°C to 125°C, 1000 cycles
- Objective: Determine the resistance of TIM to extremes of high and low temperatures, and its ability to withstand cyclical stresses

**HLT2000 Delta T of Thermal Shock**

**-40°C~125°C x 1000cycles**



- Ramp time: <20sec
- Dwelling time @ -40°C and 125°C: 1hr



Thermal Shock chamber

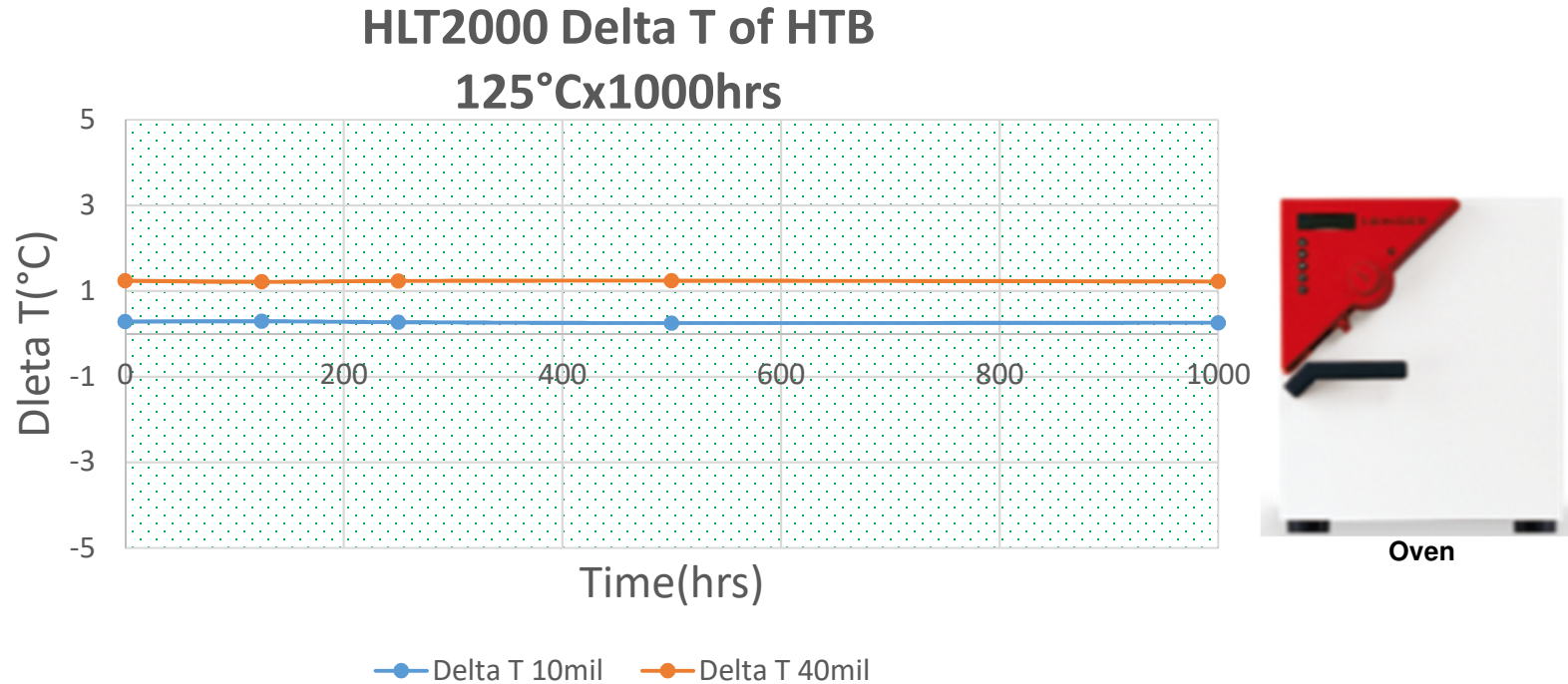
**HLT2000 remain reliable up to 1000 cycles for thermal shock test.**



## High Temperature Baking

Standard: JESD22-A103C

- Testing Condition: 125°C, 1000 hours
- Objective: Accelerate changes in TIM's material and performance characteristics relative to prolonged and elevated temperature.



**HLT2000 remain reliable up to 1000hrs for 125°C baking**



**THANK YOU**

**Honeywell**

**[www.honeywell.com](http://www.honeywell.com)**